Applicant(s)/Patent Under Reexamination Application/Control No. 10/733,453 OYA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1756 Mark A. Chapman **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,733,945	05-2004	Hirota et al.	430/125
*	В	US-6,671,476	12-2003	Saiki, Atsuna	399/111
	С	US-			
	D	US-			
	Ε	US-			
	F	US-		·	
	G	US-			
	Η	US-			
	1	US-			
	J	US-			
	К	US-			
•	L	US-		·	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р				·	
	Q					
	R					
	S					·
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W.	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.